

## SEMITRANS<sup>®</sup> 3

### **Trench IGBT Modules**

### SKM600GB07E3

#### Features\*

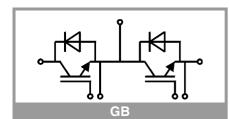
- V<sub>CE(sat)</sub> with positive temperature coefficient
- High short circuit capability, self limiting to 6 x I<sub>cnom</sub>
- Fast & soft switching inverse CAL diodes
- Insulated copper baseplate using DCB Technology (Direct Copper Bonding)
- · With integrated gate resistor

### **Typical Applications**

- AC inverter drives
- UPS
- Electronic welders

#### Remarks

- Case temperature limited to T<sub>c</sub> = 125°C max.
- Recommended  $T_{op} = -40 \dots +150^{\circ}C$
- Product reliability results valid for T = 150°C
- for  $T_j = 150^{\circ}C$ • Use of soft R<sub>G</sub> necessary



Absolut	te Maximum Ratin	gs		
Symbol	Conditions		Values	Unit
IGBT				
V <sub>CES</sub>	T <sub>j</sub> = 25 °C		650	V
lc	T <sub>j</sub> = 175 °C	T <sub>c</sub> = 25 °C	852	А
		T <sub>c</sub> = 80 °C	644	А
I <sub>Cnom</sub>			600	A
I <sub>CRM</sub>	I <sub>CRM</sub> = 3 x I <sub>Cnom</sub>		1800	А
V <sub>GES</sub>			-20 20	V
t <sub>psc</sub>	$V_{CC} = 360 V$ $V_{GE} \le 15 V$ $V_{CES} \le 650 V$	T <sub>j</sub> = 150 °C	6	μs
Tj		<b>I</b>	-40 175	°C
Inverse	diode			·
V <sub>RRM</sub>	T <sub>j</sub> = 25 °C		650	V
I <sub>F</sub>	T 475 00	T <sub>c</sub> = 25 °C	812	А
	— T <sub>j</sub> = 175 °C	T <sub>c</sub> = 80 °C	595	А
I <sub>Fnom</sub>		<b>!</b>	600	А
I <sub>FRM</sub>	I <sub>FRM</sub> = 2 x I <sub>Fnom</sub>		1200	A
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms, sin 180°, T <sub>j</sub> = 25 °C		4320	А
Tj			-40 175	°C
Module				•
I <sub>t(RMS)</sub>			500	А
T <sub>stg</sub>	module without TIM		-40 125	°C
V <sub>isol</sub>	AC sinus 50 Hz,	t = 1 min	4000	V

Characte	eristics					
Symbol	Conditions	min.	typ.	max.	Unit	
IGBT						
V <sub>CE(sat)</sub>	$I_{\rm C} = 600  {\rm A}$	T <sub>j</sub> = 25 °C		1.45	1.90	V
	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 150 °C		1.70	2.10	V
V <sub>CE0</sub>	chiplevel	T <sub>j</sub> = 25 °C		0.90	1.00	V
		T <sub>j</sub> = 150 °C		0.82	0.90	V
r <sub>CE</sub> V <sub>GE</sub> = 15 V chiplevel	V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25 °C		0.92	1.50	mΩ
	chiplevel	T <sub>j</sub> = 150 °C		1.47	2.00	mΩ
V <sub>GE(th)</sub>	$V_{GE}=V_{CE}$ , $I_C = 9.6 \text{ mA}$		5.1	5.8	6.4	V
I <sub>CES</sub>	$V_{GE} = 0 V, V_{CE} = 65$	0 V, T <sub>j</sub> = 25 °C			0.3	mA
Cies	$V_{or} = 25 V$	f = 1 MHz		37.0		nF
Coes		f = 1 MHz		2.32		nF
C <sub>res</sub>		f = 1 MHz		1.10		nF
$Q_{G}$	V <sub>GE</sub> = - 8 V+ 15 V			4800		nC
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			0.5		Ω
t <sub>d(on)</sub>	$I_{C} = 600 \text{ A}$ $V_{GE} = +15/-7.5 \text{ V}$ $R_{G \text{ on}} = 3 \Omega$	T <sub>j</sub> = 150 °C		83		ns
t <sub>r</sub>		T <sub>j</sub> = 150 °C		121		ns
Eon		T <sub>j</sub> = 150 °C		20		mJ
t <sub>d(off)</sub>		T <sub>j</sub> = 150 °C		1100		ns
t <sub>f</sub>		T <sub>j</sub> = 150 °C		93		ns
E <sub>off</sub>		T <sub>j</sub> = 150 °C		37		mJ
R <sub>th(j-c)</sub>	per IGBT				0.066	K/W
R <sub>th(c-s)</sub>	per IGBT ( $\lambda_{grease}$ =0.81 W/(m*K))			0.033		K/W
R <sub>th(c-s)</sub>	per IGBT, pre-applied phase change material			0.021		K/W



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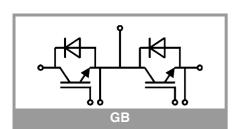
### **Typical Applications**

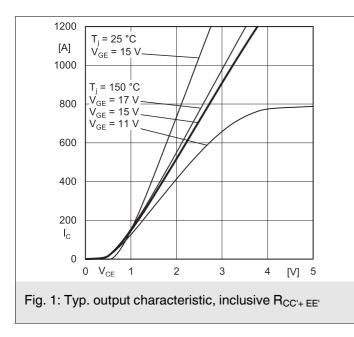
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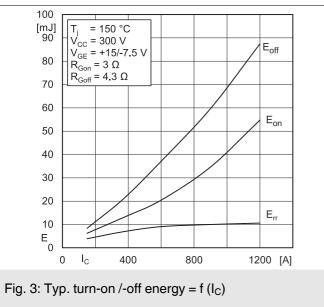
#### Remarks

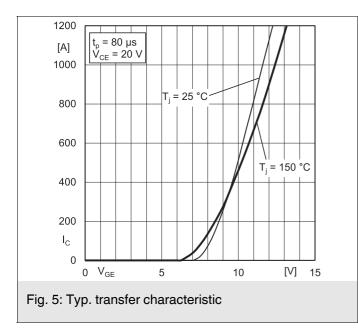
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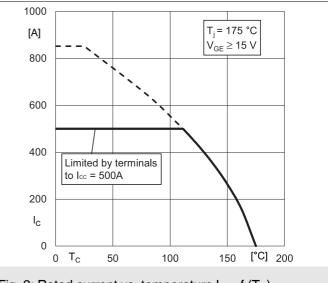
Characte	ristics					
Symbol	Conditions	min.	typ.	max.	Unit	
Inverse d	iode					
$V_F = V_{EC}$	I <sub>F</sub> = 600 A	T <sub>j</sub> = 25 °C		1.40	1.76	V
	V <sub>GE</sub> = 0 V chiplevel	T <sub>j</sub> = 150 °C		1.38	1.77	V
V <sub>F0</sub>	chiplevel	T <sub>j</sub> = 25 °C		1.04	1.24	V
		T <sub>j</sub> = 150 °C		0.85	0.99	V
r <sub>F</sub>	chiplevel	T <sub>j</sub> = 25 °C		0.60	0.88	mΩ
		T <sub>j</sub> = 150 °C		0.89	1.31	mΩ
I <sub>RRM</sub>	$I_{F} = 600 \text{ A}$ di/dt <sub>off</sub> = 4940 A/µs V <sub>GE</sub> = +15/-7.5 V V <sub>CC</sub> = 300 V	T <sub>j</sub> = 150 °C		390		Α
Q <sub>rr</sub>		T <sub>j</sub> = 150 °C		54		μC
E <sub>rr</sub>		T <sub>j</sub> = 150 °C		9.1		mJ
R <sub>th(j-c)</sub>	per diode				0.096	K/W
R <sub>th(c-s)</sub>	per diode (λ <sub>grease</sub> =0.81 W/(m*K))			0.038		K/W
R <sub>th(c-s)</sub>	per diode, pre-applied phase change material			0.028		K/W
Module						
L <sub>CE</sub>				15		nH
R <sub>CC'+EE'</sub>	measured per switch	T <sub>C</sub> = 25 °C		0.55		mΩ
		T <sub>C</sub> = 125 °C		0.85		mΩ
R <sub>th(c-s)1</sub>	calculated without thermal coupling (λ <sub>grease</sub> =0.81 W/(m*K))			0.0088		K/W
R <sub>th(c-s)2</sub>	including thermal coupling, T <sub>s</sub> underneath module $(\lambda_{grease}=0.81 \text{ W/(m^{*}K)})$			0.014		K/W
R <sub>th(c-s)2</sub>	including thermal coupling, T <sub>s</sub> underneath module, pre-applied phase change material			0.010		K/W
Ms	to heat sink M6		3		5	Nm
M <sub>t</sub>		to terminals M6	2.5		5	Nm
	1					Nm
w					325	g

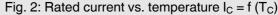


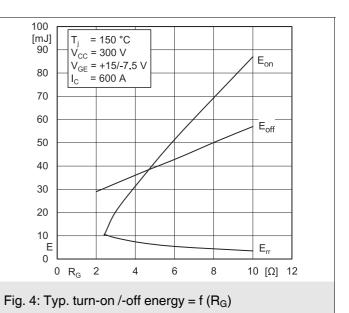


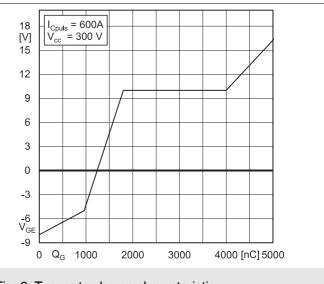


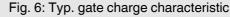


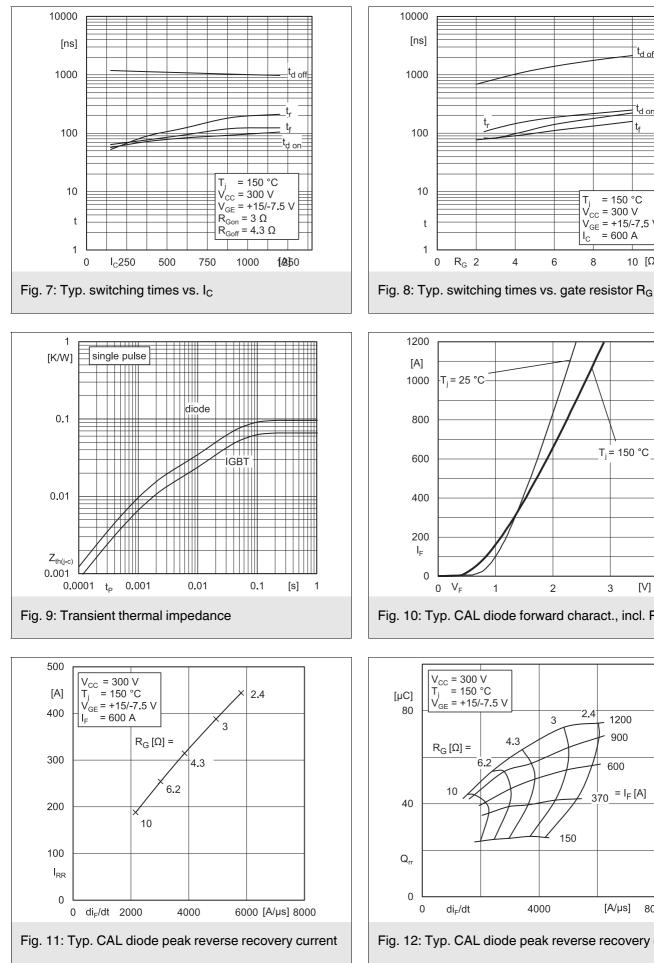


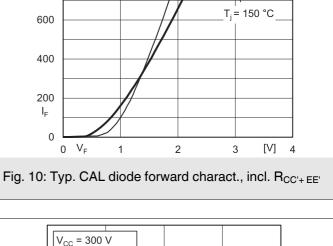












2.4

3

1200

⁻t<sub>d off</sub>

t<sub>d on</sub>

10 [Ω] 12

tf

= 150 °C

 $V_{GE} = +15/-7.5 V$  $I_C = 600 A$ 

 $V_{\rm CC} = 300 \, \rm V$ 

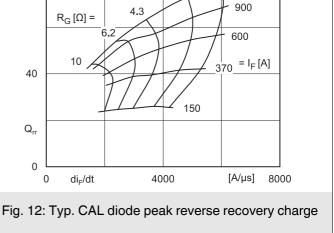
T<sub>i</sub>

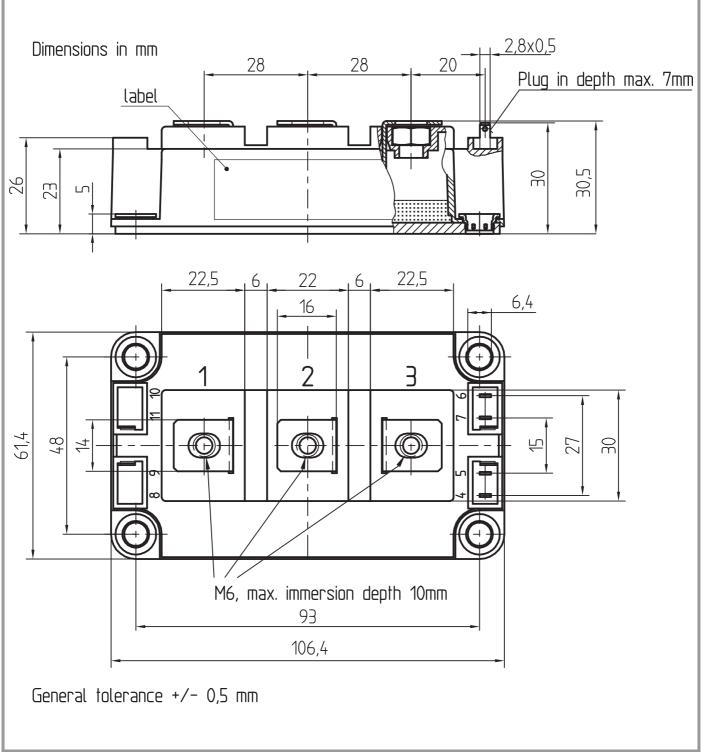
 $I_{C}$ 

8

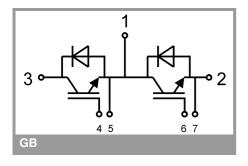
6

4









Rev. 4.0 – 29.05.2020

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

#### **\*IMPORTANT INFORMATION AND WARNINGS**

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